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Application No. 09/458,565

**Information Disclosure Statement** by Applicant (Use several sheets if necessary)

Applicant Dermer et al.

Filing Date

**Group Art Unit** 2624

**U.S. Patent Documents** Publication Filing Date **Document** Examiner Desig. Patentee Class If Appropriate **Subclass** ID Number Date Initial 4,931,861 06/1990 Taniguchi AA 03/1994 AB 5,295,236 Bjorge et al AC 5,313,570 05/1994 Dermer et al. AD 5,402,534 03/1995 Yeomans AE 5,412,877 05/1995 McKendrick AF 5,438,653 08/1995 Boenke et al 07/1996 AG Deutsch et al 5,542,052 AΗ 11/1996 Ishida et al 5,579,405 ΑI 5,602,976 02/1997 Cooper et al AJ 03/1997 5,613,046 Dermer ΑK 5,638,498 06/1997 Tyler et al AL 5,666,543 09/1997 Gartland AM 5,668,931 09/1997 Dermer AN 5,760,779 06/1998 Yamashita, et al AO 11/1998 5,832,127 Healey AP 6,031,544 02/2000 Yhann 05/2001 AQ 6,236,754 Harrington

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